

The Silicon Pixel Detector (SPD) for the ALICE Experiment

V. Manzari/INFN Bari, Italy for the SPD Project in the ALICE Experiment

INFN and Università Bari, Comenius University Bratislava, INFN and Università Catania, CERN Geneva, Institute of Experimental Physics Kosice, INFN Laboratori Nazionali Legnaro (LNL), INFN and Università Padova, INFN and Università Salerno, INFN and Università Udine



ALICE Layout: the ITS and the SPD

Silicon Pixel Detector





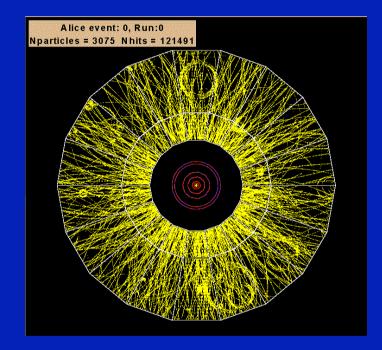
- · B-field < 0.5 T
- Charged particle multiplicities of up to 8000 per unit of rapidity (head-on Pb-Pb collisions)



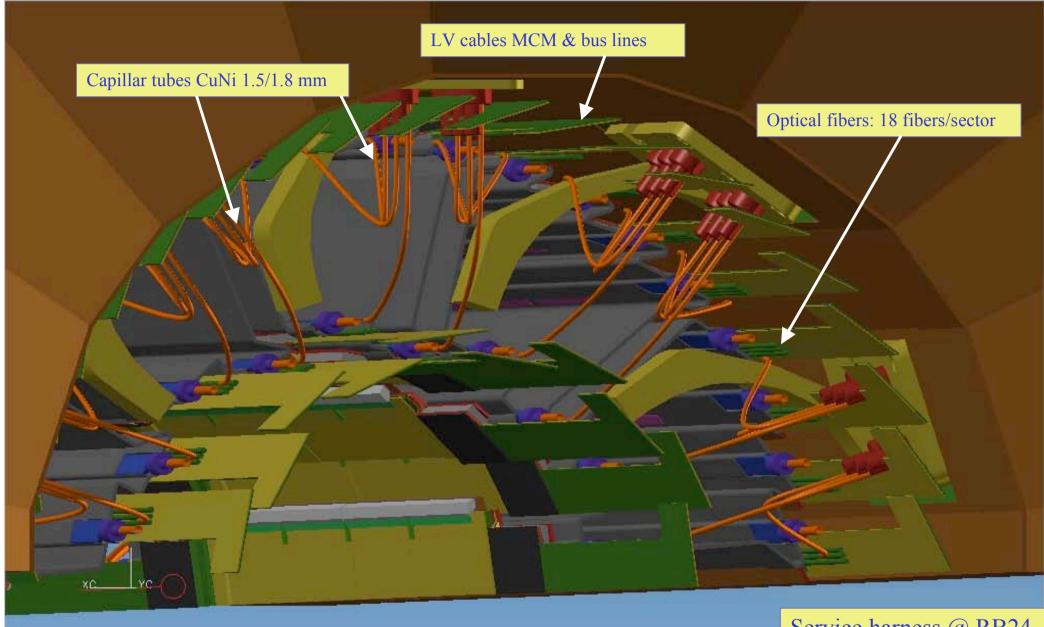
The ALICE SPD



- Secondary vertexing capability (c,b)
- Track impact parameter resolution: $r\phi$ < 50 μ m (pt >1.3 GeV/c)
- Two barrel layers: R_i = 39 mm, R_o = 76 mm
- Inner layer pseudorapidity coverage: $|\eta|$ < 1.95 [ITS coverage $|\eta| \approx 0.8$]
- Total Si surface: ≈ 0.24 m²
- Individual pixel cell: 50 μ m (r ϕ) x 425 μ m (z)
- Occupancy (central Pb-Pb): < 2%
- Radiation level at the inner layer for 10 years standard running: TID $\approx 5 kGy$, F $\approx 6 \cdot 10^{12}$ (1MeV n_{eq})/cm² (working values!)



Track densities at r = 4 cm (1st pixel layer): up to $100/\text{cm}^2$



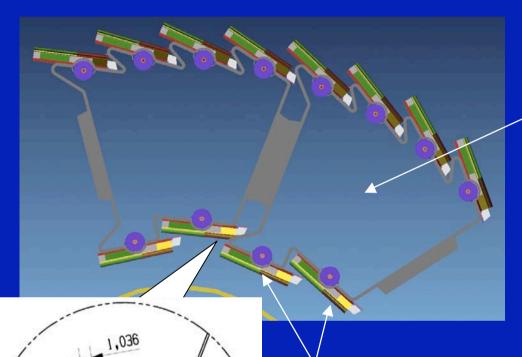
BOTTOM WORK

Service harness @ RB24



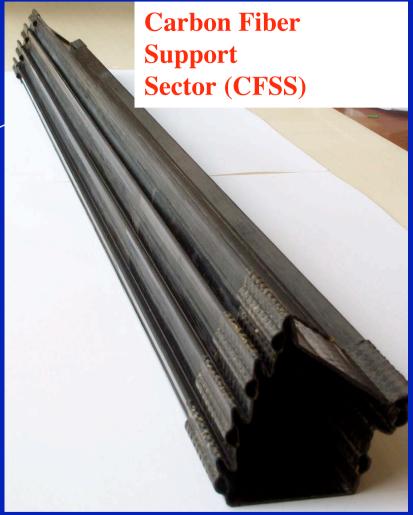
SPD Mounting





6 staves/sector

(2 from inner layer and 4 from outer layer)

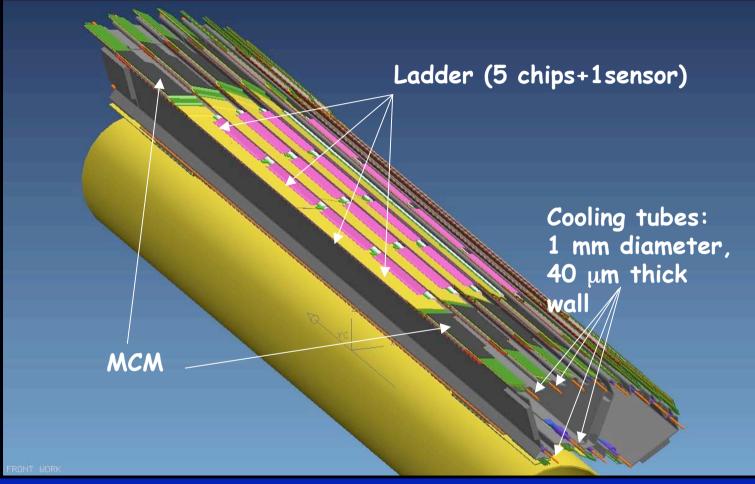


Material budget (each layer): ≈ 0.9% X₀ (Si \approx 0.37, cooling \approx 0.3, bus \approx 0.17, CFSS \approx 0.1) V. Manzari - Quark Matter 2004 - Oakland



SPD Sector



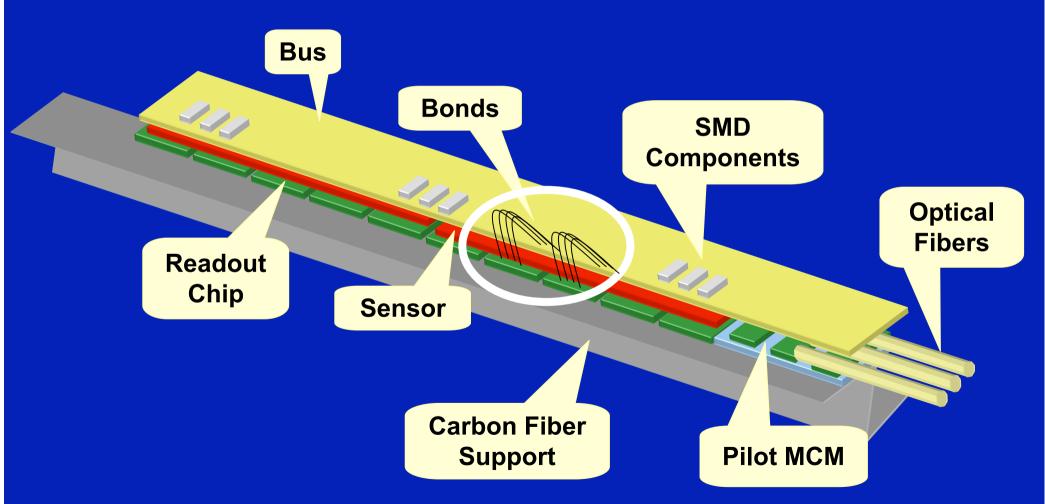


- FE power dissipation/sector: ≈ 150 W
- Cooling: C_4F_{10} (evaporative), operating temperature $\approx 25^{\circ}C$
- · Cooling test with a prototype module is currently under way



SPD Half-Stave

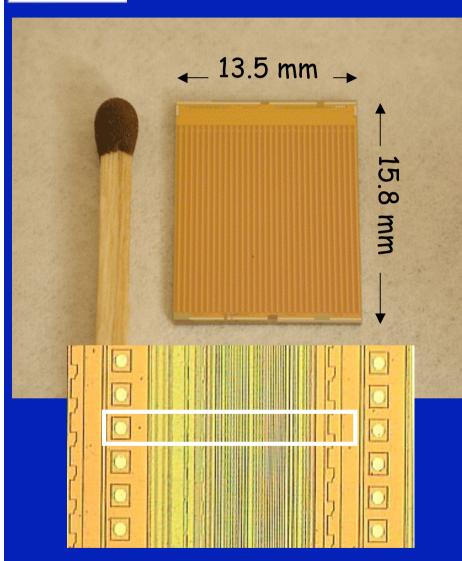


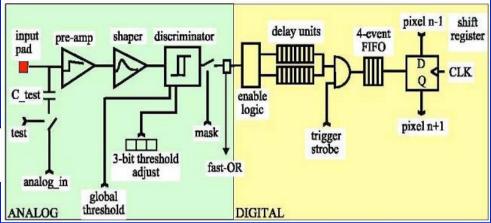




ALICELHCb1 Pixel ASIC





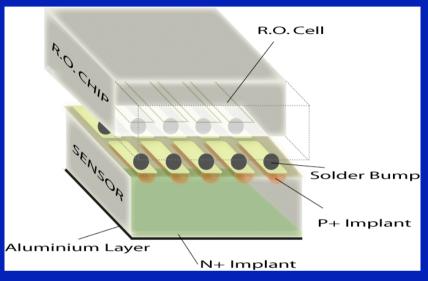


- · Mixed signal (analogue, digital)
- Produced in a commercial 0.25 µm CMOS process (8" wafers)
- Radiation tolerant design (enclosed gates, guard rings)
- 8192 pixel cells
- 50 μm (rφ) x 425 μm (z) pixel cell
- · ~100 μW/channel
- ~1000 e⁻ mean threshold (~200 e⁻RMS)
- · ~120 e- mean noise

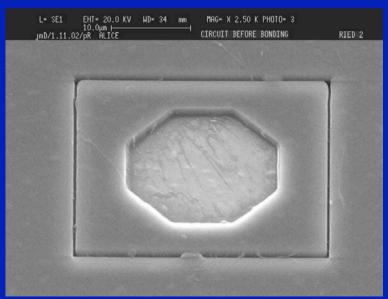


VTT Bump-Bonding

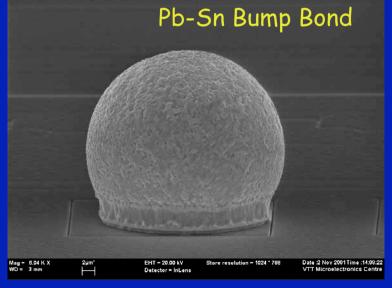




- · VTT/Finland
- Pb-Sn solder bumps: ~25μm diameter
- p-in-n silicon sensor: 200µm thick (Canberra)
- IBM readout chips: $750\mu m$ native thickness thinned to $150\mu m$ after bump deposition
- · stand-off: ~20µm (Pb-Sn)



SEM Pictures





SPD Ladder



- 1 p-in-n sensor (200µm thick)
- 5 readout chips (150µm thick)
- · 4960 bump bonds
- I_{det} @50V=120-200nA, V_{fd}=15V



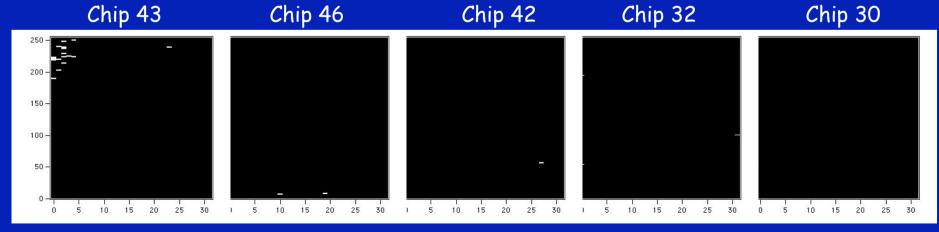
<u>Sr-Measurements</u>:

Working pixels
Missing pixels

 Chip43
 Chip46
 Chip42
 Chip32
 Chip30

 99.7%
 99.95%
 99.98%
 99.98%
 100%

 28
 4
 2
 2
 0

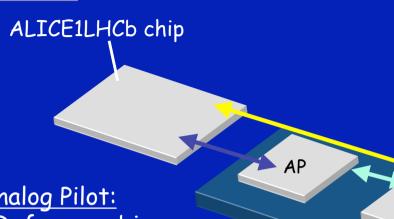




Multi Chip Module (MCM)

DP





Multi Chip Module (MCM)

- Analog Pilot (AP)
- · Digital Pilot (DP)

GOL

- GOL (Giga-bit optical link)
- Optical Module (OM)

Analog Pilot:

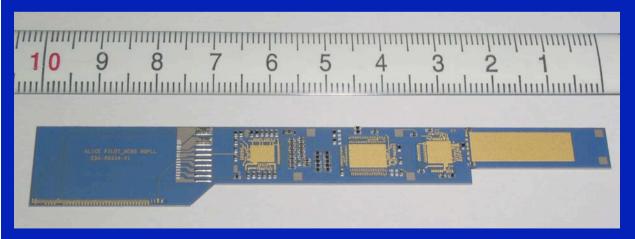
- · Reference bias
- ADC (T, V and I monitor)

Digital Pilot:

• Timing, Control and Readout

Optical Module

- · Laser and pin diode
- · In Si-case
- 1.2 \times 17 \times 5.5 mm³
- Outogoing Data Stream



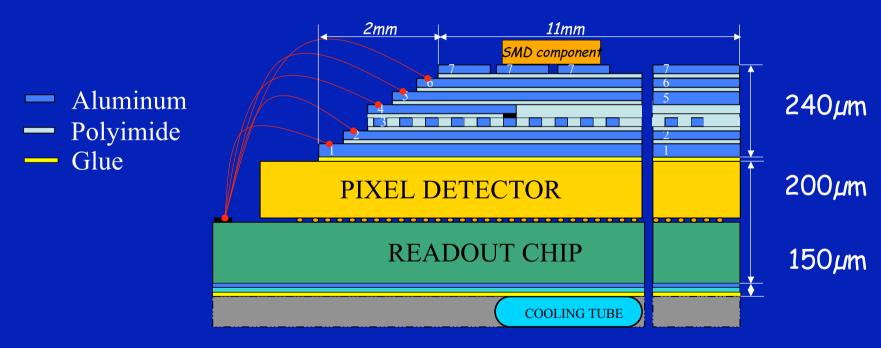
- Trigger and JTAG configuration data
- · LHC 40 MHz clock



SPD Multilayer Bus

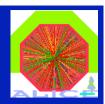


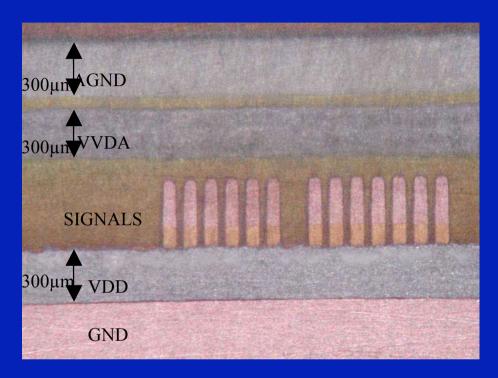
- 5 layer Al-Kapton flex 240 μ m thick
- · wire bonds to the readout chips and MCM
- provides data -, control- and power-lines between readout chips and MCM

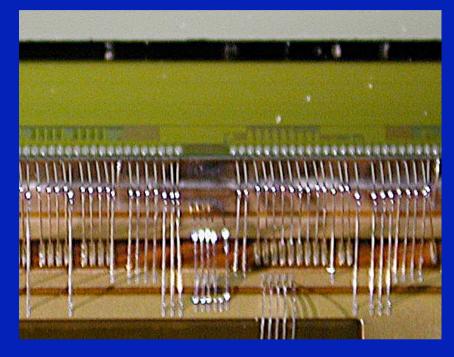




Wire Bonding on Bus and Ladder





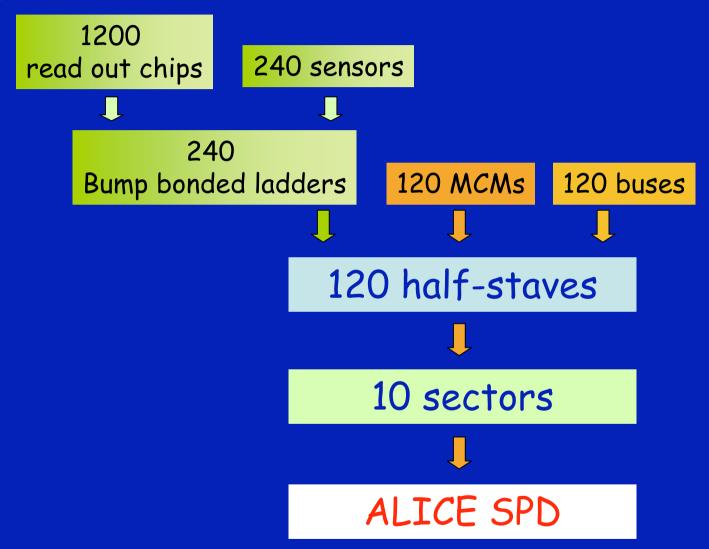


- ~1100 Wire bonds/half-stave
- · 25µm diameter wire
- Bonding pads on the bus: $80 \times 300 \mu m^2$
- · Step height: 40-60 µm



SPD Components



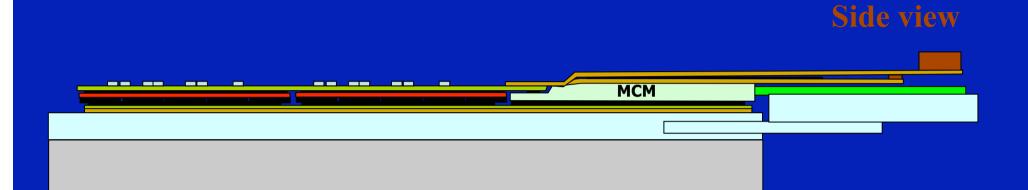


2 spare sectors + 1 pre-production sector

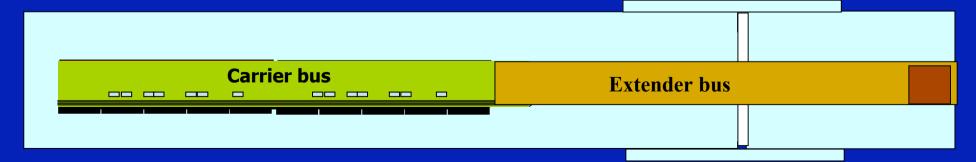


Half-stave Assembly (I)



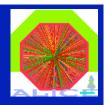


Top view





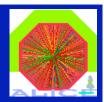
Half-stave Assembly (II)

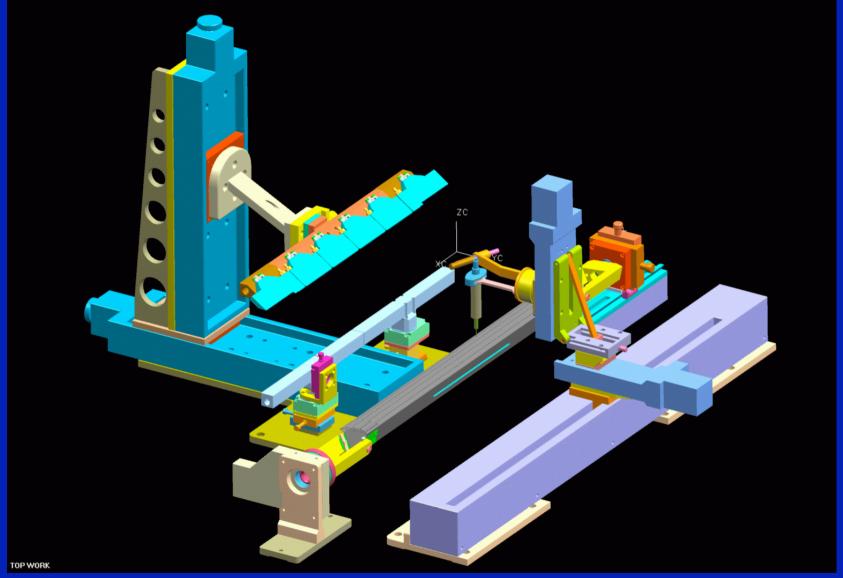






Barrel Sector Assembly System (I)

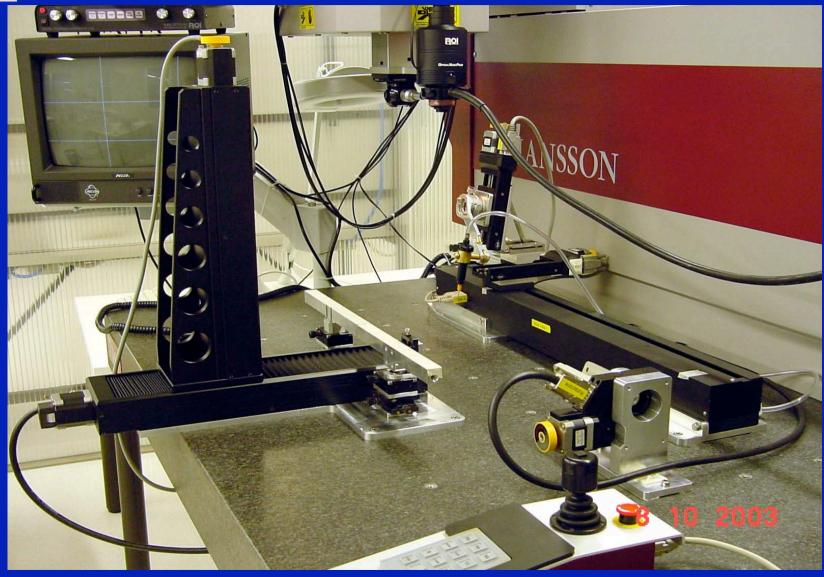






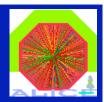
Barrel Sector Assembly System (II)

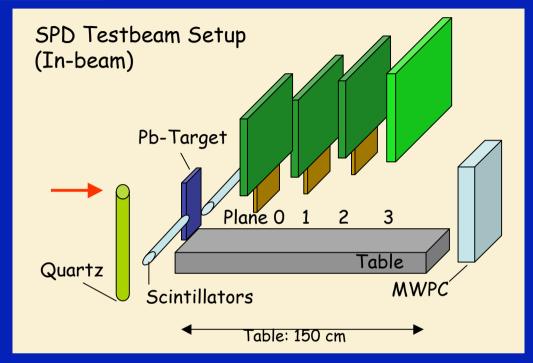






2003 Beam Test Setup





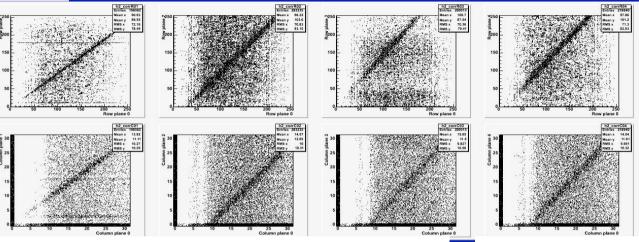


- Up to 6 planes (= 5 singles + half stave) in the beam (up to 122 880 active pixels)
- Plane 0 Plane 3 distance ≈ 80 cm, vertically adjusted for tracking
- · Target: 4 mm Pb
- Trigger: quartz counter (beam) + $2 \text{ cm} \times 2 \text{ cm}$ scintillator (interactions)
- · Half-stave read out through MCM including optical module
- · 2.8 GB of data collected
- DCS (PVSS) system for HV

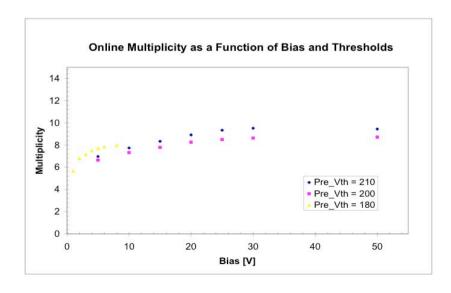


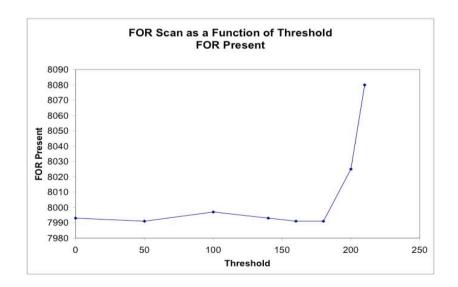
First Results (very preliminary)





Hit correlations between the planes (stripped In ion beam)



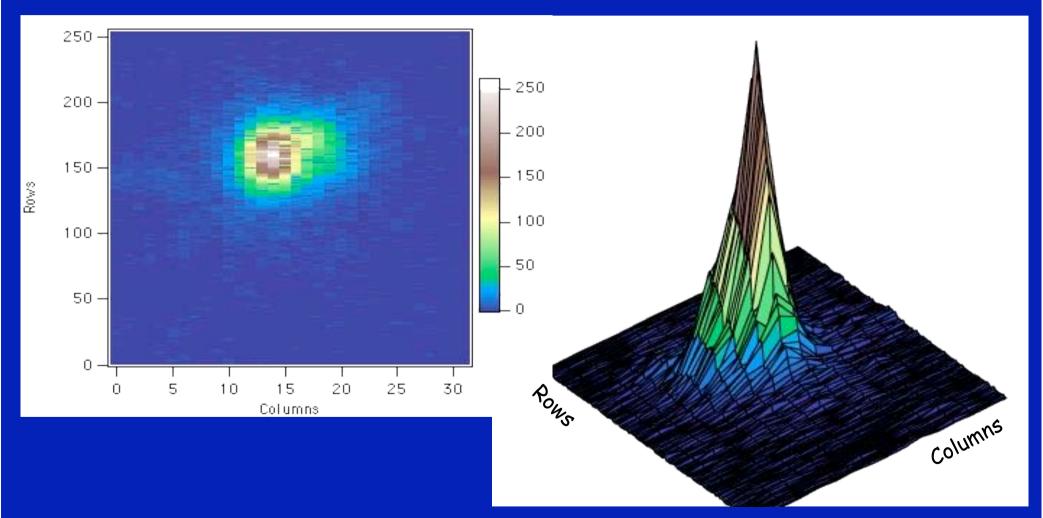




Indium Ion Beam on Single Assembly



Beamspot (32V sensor bias) 104 ions/spill





Summary



- · Challenging constraints on geometry and material budget.
- Specific technology developments and extensive tests of the SPD components have been carried out.
- Half-stave and Sector assembly procedures have been developed and tests with dummy components are currently being completed.
- Construction of prototypes with real components has been started:

 a half-stave with real ladders has been delivered for cooling test, a half-stave for the validation of the multilayer bus with working ladders is under construction.
- SPD components have been tested in a heavy-ion beam (October 2003): offline analysis of collected data ongoing.